Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/919,873	NAMIKI, HIDEO
Examiner	Art Unit
Kevin Mew	2664

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Class	Subclass	Date	Examiner
370	386	1/30/06	MEW
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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